#### **PATENT**

#### IN THE UNITED STATES PATENT OFFICE

Serial No.:

NA

Filed:

Herewith

For:

DEVICE AND METHOD FOR MONITORING AN ELECTROLYTIC

**PROCESS** 

Inventors:

**Andreas Thies and Thomas Dretschkow** 

Atty Doc. No.: 256-04

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In the interest of full disclosure, the following items are herewith identified in Form

PTO-1449 and a copy of the same is hereby provided, for the convenience of the U.S. Patent and

Trademark Office.

This Information Disclosure Statement is being filed before the mailing date of the first official action.

### **U.S PATENTS**

(AA) 5,234,572, dated August 10, 1993.

(AB) 6,261,433 B1, dated July 17, 2001.

### **FOREIGN PATENTS**

(AC) 871,203, dated June 21, 1961. Relevance is cited as reference "X" in the International Search report.

(AD) DE 199 15 146 C1, dated March 26, 1999. Relevance is cited on page 2 of the specification.

(AE) 2002322592, November 8, 2002. Relevance is cited as reference "X" in the International Search report.

Respectfully submitted,

John F. McNulty

Reg. No. 23,028 Paul & Paul

2900 Two Thousand Market St.

Philadelphia, PA 19103

(215) 568-4900

# INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

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Docket Number (Optional) 256-04	1 pplication Sumb	8100

Andreas Thies and Thoma		
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U.S. PATENT DOCUMENTS												
*EXAMINER INITIAL	REF	DC	OCUMENT NUMBER	DATE	-	NAME	CLASS	SUBCLASS	FILING IF APPRO			
	AA	5,234,5	572	08/10/1993	Uchida e	Uchida et al.						
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				FORE	GN PATEN	T DOCUMENTS						
	REF	DC	DOCUMENT NUMBER DATE COUNTRY CLASS SUBG		SUBCLASS	Trans YES	lation NO					
	AC	871,20	3	06/21/1961	GREAT	BRITAIN						
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	AE	2002322592		11-08-2002	JAPAN							
				OTHER D	OCUMENT	'S (Including Author,	Title, Date, Pert	inent Pages, Etc.	.)			
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EXAMINE	EXAMINER DATE CONSIDERED											

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.